## Search Notes



Application/Control	No.

10522231 Examiner Applicant(s)/Patent Under Reexamination

MAYER ET AL.

Art Unit

Ahshik Kim

SEARCHED					
Class	Subclass	Date	Examiner		
235	454	7/25/07	AK		
	491	7/25/07	AK		
	462.41	7/25/07	AK		
	462.42	7/25/07	AK		
	457	7/25/07	AK		
356	71	7/25/07	AK		
	73.1	7/25/07	AK		

SEARCH NOTES				
Search Notes	Date	Examiner		
Updated Search	1/30/08	ak		

	INTERFERENCE SEARCH		
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